Notice of References Cited

Application/Control No. 10/784,470	Applicant(s)/Pat Reexamination TAJIMA ET AL.			
Examiner	Art Unit			
Suman Debnath	2135	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0138754 A1	09-2002	Himeno, Toshihiko	713/200
*	В	US-5,379,343	01-1995	Grube et al.	455/410
*	C	US-2001/0014884 A1	08-2001	DILLARD et al.	705/57
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Ι	US-			
	_	US-			
	J	US-			
	ĸ	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	α					
	R					
	S				V.	·
	Т					

NON-PATENT DOCUMENTS

*	* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	υ			
	v			
	w			
	x			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.